



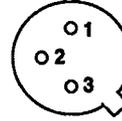
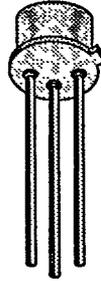
IRFF430/431/432/433

N-Channel Enhancement Mode Transistors

T-39-09

TO-205AF

BOTTOM VIEW



1 DRAIN
2 GATE
3 SOURCE

PRODUCT SUMMARY

PART NUMBER	V _{(BR)DSS} (V)	r _{DS(ON)} (Ω)	I _D (A)
IRFF430	500	1.5	2.75
IRFF431	450	1.5	2.75
IRFF432	500	2.0	2.25
IRFF433	450	2.0	2.25

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	IRFF				UNITS	
		430	431	432	433		
Drain-Source Voltage	V _{DS}	500	450	500	450	V	
Gate-Source Voltage	V _{GS}	±20	±20	±20	±20	V	
Continuous Drain Current	T _C = 25°C	I _D	2.75	2.75	2.25	2.25	A
	T _C = 100°C		2.0	2.0	1.7	1.7	
Pulsed Drain Current ¹	I _{DM}	11	11	9	9	A	
Avalanche Current (See Figure 9)	I _A	2.75	2.75	2.25	2.25	A	
Power Dissipation	T _C = 25°C	P _D	25	25	25	25	W
	T _C = 100°C		10	10	10	10	
Operating Junction & Storage Temperature Range	T _J , T _{stg}	-55 to 150				°C	
Lead Temperature (1/16" from case for 10 sec.)	T _L	300					

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THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	R _{thJC}		5.0	K/W
Junction-to-Ambient	R _{thJA}		175	

¹Pulse width limited by maximum junction temperature (refer to transient thermal impedance data, Figure 11).

IRFF430/431/432/433

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

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PARAMETER	SYMBOL	TEST CONDITIONS	TYP	LIMITS		UNIT	
				MIN	MAX		
STATIC							
Drain-Source Breakdown Voltage	IRFF430, 432 IRFF431, 433	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$		500 450	V	
Gate Threshold Voltage		$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$		2.0 4.0		
Gate-Body Leakage		I_{GBSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$		± 100	nA	
Zero Gate Voltage Drain Current		I_{DSS}	$V_{DS} = V_{(BR)DSS}, V_{GS} = 0\text{ V}$		250	μA	
			$V_{DS} = 0.8 \times V_{(BR)DSS}, V_{GS} = 0\text{ V}, T_J = 125^\circ\text{C}$		1000		
On-State Drain Current ¹	IRFF430, 431 IRFF432, 433	$I_{D(ON)}$	$V_{DS} = 5\text{ V}, V_{GS} = 10\text{ V}$		2.75 2.25	A	
Drain-Source On-State Resistance ¹	IRFF430, 431 IRFF432, 433	$r_{DS(ON)}$	$V_{GS} = 10\text{ V}, I_D = 1.5\text{ A}$	1.2 1.5		1.5 2.0	Ω
			$V_{GS} = 10\text{ V}, I_D = 1.5\text{ A}$ $T_J = 125^\circ\text{C}$	2.5 3.3		3.3 4.4	
Forward Transconductance ¹		g_{fs}	$V_{DS} = 15\text{ V}, I_D = 1.5\text{ A}$	2.8	1.5	S	
DYNAMIC							
Input Capacitance		C_{iss}	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	750		pF	
Output Capacitance		C_{oss}		120			
Reverse Transfer Capacitance		C_{rss}		50			
Total Gate Charge ²		Q_g	$V_{DS} = 0.5 \times V_{(BR)DSS}, V_{GS} = 10\text{ V}, I_D = 2.75\text{ A}$	20	15	34	nC
Gate-Source Charge ²		Q_{gs}		3.6	1.8	4.7	
Gate-Drain Charge ²		Q_{gd}		9	7.6	17	
Turn-On Delay Time ²		$t_{d(on)}$	$V_{DD} = 225\text{ V}, R_L = 150\ \Omega$ $I_D \approx 1.5\text{ A}, V_{GEN} = 10\text{ V}, R_G = 7.5\ \Omega$	11		30	ns
Rise Time ²		t_r		12		30	
Turn-Off Delay Time ²		$t_{d(off)}$		45		55	
Fall Time ²		t_f		22		30	
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_C = 25^\circ\text{C}$)							
Continuous Current	IRFF430, 431 IRFF432, 433	I_S			2.75 2.25	A	
Pulsed Current ³	IRFF430, 431 IRFF432, 433	I_{SM}			11.0 9.0		
Forward Voltage ¹	IRFF430, 431 IRFF432, 433	V_{SD}	$I_F = I_S, V_{GS} = 0\text{ V}$		1.4 1.3	V	
Reverse Recovery Time		t_{rr}	$I_F = I_S, di_F/dt = 100\text{ A}/\mu\text{s}$	260		ns	
Reverse Recovery Charge		Q_{rr}		1.5		μC	

¹Pulse test: Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³Pulse width limited by maximum junction temperature (refer to transient thermal impedance data, Figure 11).



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TYPICAL CHARACTERISTICS (25°C Unless Otherwise Specified)

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Figure 1. Output Characteristics

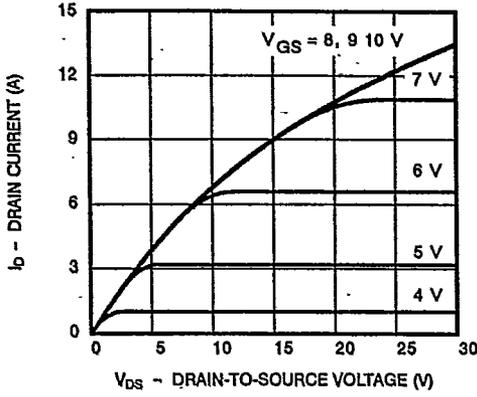


Figure 2. Transfer Characteristics

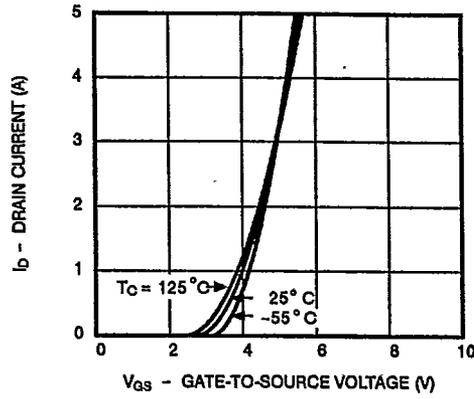


Figure 3. Transconductance

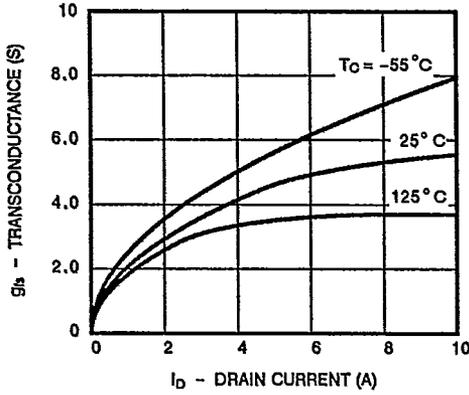
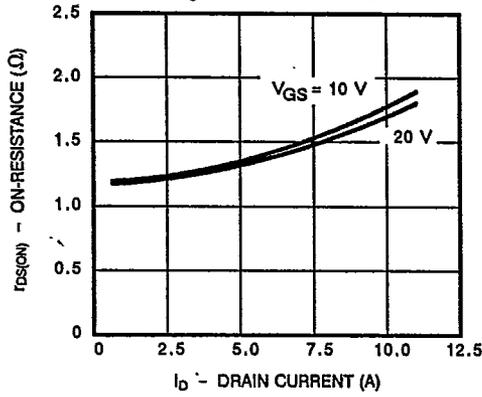


Figure 4. On-Resistance



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Figure 5. Capacitance

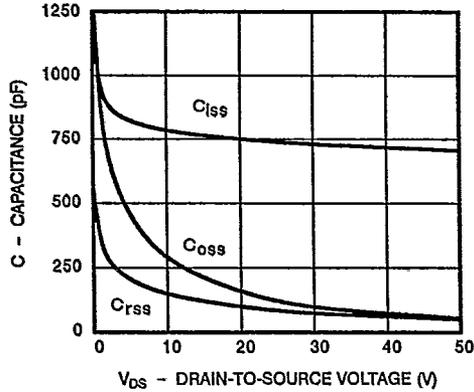
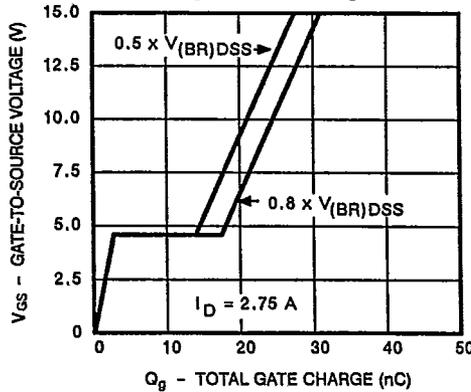


Figure 6. Gate Charge



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TYPICAL CHARACTERISTICS (Cont'd)

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Figure 7. On-Resistance vs. Junction Temperature

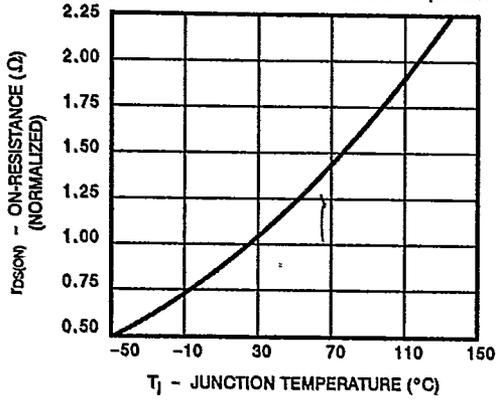
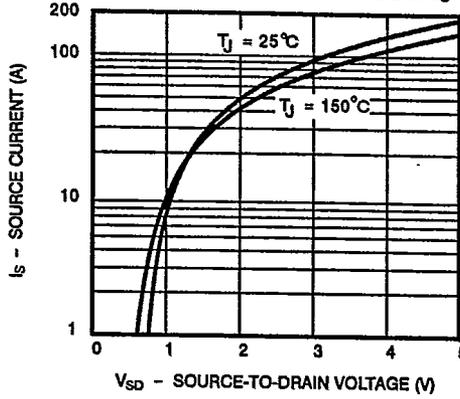


Figure 8. Source-Drain Diode Forward Voltage



THERMAL RATINGS

Figure 9. Maximum Avalanche and Drain Current vs. Case Temperature

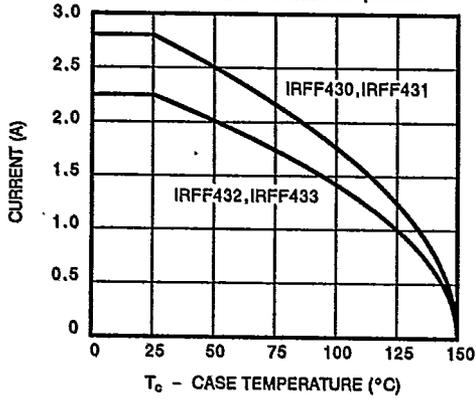


Figure 10. Safe Operating Area

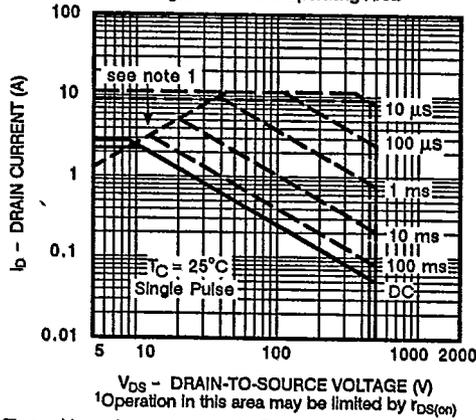


Figure 11. Normalized Effective Transient Thermal Impedance, Junction-to-Case

